



CMOS High Voltage Logic – CD4011B

Quad 2-Input NAND Gate Logic IC in bare die form

Rev 1.0
21/11/17

Description

The CD4011B is fabricated using a 3µm 15CMOS process. The device has equal source and sink current capabilities and conforms to standard B series output drive. Device outputs are buffered which improves transfer characteristics by providing very high gain. The device is capable of driving x2 low power TTL loads or x1 LSTTL load.

Features:

- High Input Voltage up to 20V
- Symmetrical Output Characteristics
- Max input current 1µA at 18V over full Military Temperature Range
- Low Power TTL compatible
- Specified at 5V, 10V & 15V
- Direct drop-in replacement for obsolete components in long term programs.

Ordering Information

The following part suffixes apply:

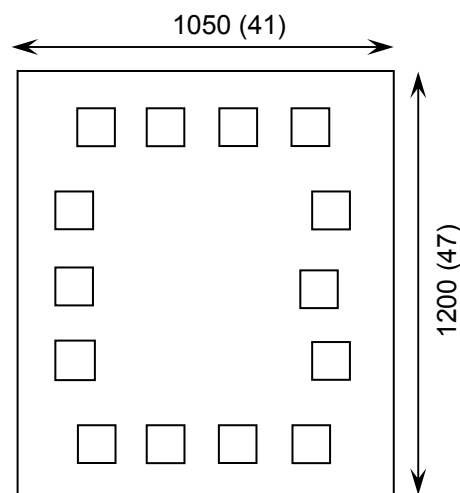
- No suffix - MIL-STD-883 /2010B Visual Inspection
- “H” - MIL-STD-883 /2010B Visual Inspection
+ MIL-PRF-38534 Class H LAT
- “K” - MIL-STD-883 /2010A Visual Inspection (Space)
+ MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

For more information on LAT flows please see below.

www.siliconsupplies.com/quality/bare-die-lot-qualification

Die Dimensions in µm (mils)



Supply Formats:

- Default – Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape – On request
- Unsawn Wafer – On request
- Die Thickness <> 350µm(14 Mils) – On request
- Assembled into Ceramic Package – On request

Mechanical Specification

Die Size (Unsawn)	1050 x 1200 41 x 47	µm mils
Minimum Bond Pad Size	100 x 100 3.94 x 3.94	µm mils
Die Thickness	350 (±20) 13.78 (±0.79)	µm mils
Top Metal Composition	Al 1%Si 1.1µm	
Back Metal Composition	N/A – Bare Si	



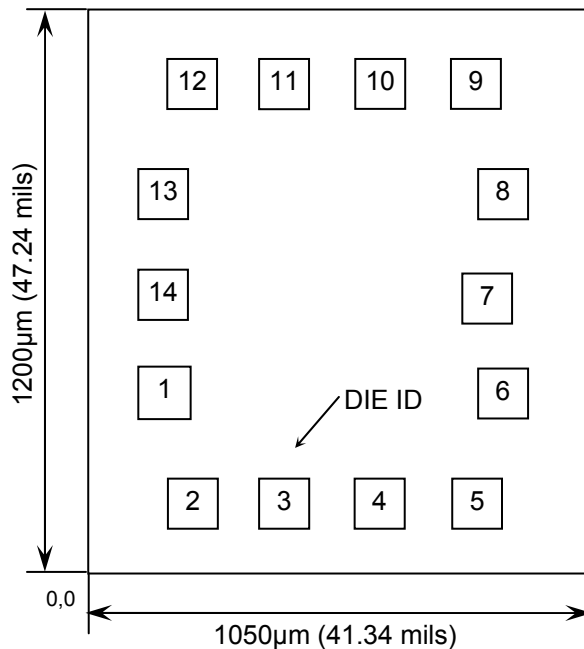


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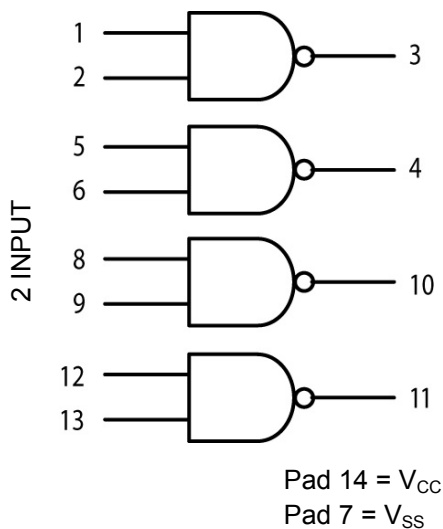
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Pad Layout and Functions



PAD	FUNCTION	COORDINATES (mm)	
		X	Y
1	1A	0.108	0.340
2	2A	0.165	0.108
3	OUT A	0.362	0.108
4	OUT B	0.566	0.108
5	1B	0.763	0.108
6	2B	0.820	0.340
7	V _{SS}	0.785	0.542
8	1C	0.820	0.759
9	2C	0.763	0.991
10	OUT C	0.566	0.991
11	OUT D	0.362	0.991
12	1D	0.165	0.991
13	2D	0.108	0.759
14	V _{DD}	0.108	0.548
CONNECT CHIP BACK TO V _{DD} OR FLOAT			

Circuit Schematic



Truth Table

INPUTS		OUTPUT
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L
H = High level (steady state) L = Low level (steady state)		





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Absolute Maximum Ratings¹

PARAMETER	SYMBOL	VALUE	UNIT
DC Supply Voltage (Referenced to V_{SS})	V_{DD}	-0.5 to +20	V
DC Input or Output Voltage (Referenced to V_{SS})	V_{IN}, V_{OUT}	-0.5 to $V_{DD}+0.5$	V
Storage Temperature Range	T_{STG}	-65 to 150	°C
Input Current or Output Current (per Pad)	I_{IN}, I_{OUT}	±10	mA
Power Dissipation in Still Air ²	P_D	750	mW

1. Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability. 2. Measured in plastic DIP package, results in die form are dependent on die attach and assembly method.

Recommended Operating Conditions³ (Voltages referenced to V_{SS})

PARAMETER	SYMBOL	MIN	MAX	UNITS
Supply Voltage	V_{DD}	3.0	18	V
DC Input Voltage, Output Voltage	V_{IN}, V_{OUT}	0	V_{DD}	V
Operating Temperature Range	T_J	-55	+125	°C

3. This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{IN} and V_{OUT} should be constrained to the range $V_{SS} \leq (V_{IN} \text{ or } V_{OUT}) \leq V_{DD}$. Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V_{SS} or V_{DD}). Unused outputs must be left open.

DC Electrical Characteristics (Voltages referenced to V_{SS})

PARAMETER	SYMBOL	V_{DD}	CONDITIONS	LIMITS			UNITS
				25°C	85°C	FULL RANGE ⁴	
Minimum High-Level Input Voltage	V_{IH}	5V	$V_{OUT} = 0.5V$	3.5	3.5	3.5	V
		10V	$V_{OUT} = 1.0V$	7	7	7	
		15V	$V_{OUT} = 1.5V$	11	11	11	
Maximum Low-Level Input Voltage	V_{IL}	5V	$V_{OUT} = 0.5V$	1.5	1.5	1.5	V
		10V	$V_{OUT} = 1.0V$	3	3	3	
		15V	$V_{OUT} = 1.5V$	4	4	4	
Minimum High-Level Output Voltage	V_{OH}	5V	$V_{IN} = V_{SS}$	4.95	4.95	4.95	V
		10V		9.95	9.95	9.95	
		15V		14.95	14.95	14.95	
Maximum Low-Level Output Voltage	V_{OL}	5V	$V_{IN} = V_{DD} \text{ or } V_{SS}$	0.05	0.05	0.05	V
		10V		0.05	0.05	0.05	
		15V		0.05	0.05	0.05	
Maximum Input Leakage Current	I_{IN}	18V	$V_{IN} = V_{DD} \text{ or } V_{SS}$	±0.1	±0.1	±1.0	µA
Maximum Quiescent Supply Leakage Current	I_{CC}	5V	$V_{IN} = V_{DD} \text{ or } V_{SS}$ $I_{OUT} = 0\mu A$	0.25	0.25	7.5	µA
		10V		0.5	0.5	15	
		15V		1.0	1.0	30	
		20V		5.0	5.0	150	





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DC Electrical Characteristics Continued (Voltages referenced to V_{SS})

PARAMETER	SYMBOL	V_{DD}	CONDITIONS	LIMITS			UNITS
				25°C	85°C	FULL RANGE ⁴	
Minimum Output Low (Sink) Current	I_{OL}	5V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OL} = 0.4V$	0.64	0.51	0.36	mA
		10V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OL} = 0.5V$	1.6	1.3	0.9	
		15V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OL} = 1.5V$	4.2	3.4	2.4	
Minimum Output High (Source) Current	I_{OH}	5V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OH} = 2.5V$	-2.0	-1.6	-1.15	V
		5V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OH} = 4.6V$	-0.64	-0.51	-0.36	
		10V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OH} = 9.5V$	-1.6	-1.3	-0.9	
		15V	$V_{IN} = V_{DD}$ or V_{SS} $V_{OH} = 13.5V$	-4.2	-3.4	-2.4	

4. -55°C ≤ T_J ≤ +125°C.

AC Electrical Characteristics⁵

PARAMETER	SYMBOL	V_{DD}	CONDITIONS	TYPICAL	LIMITS		UNITS
				25°C	85°C	FULL RANGE ⁴	
Propagation Delay, Input A or B to Output Y (Figure 1)	t_{PLH}, t_{PHL}	5V	$C_L = 50pF$, $R_L = 200k\Omega$ $t_r = t_f = 20ns$	125	250	250	ns
		10V		60	100	120	
		15V		45	80	90	
Output Transition Time, Any Output (Figure 1)	t_{TLH}, t_{THL}	5V	$C_L = 50pF$, $R_L = 200k\Omega$ $t_r = t_f = 20ns$	100	250	200	ns
		10V		50	100	100	
		15V		40	80	80	
Input Capacitance	C_{IN}	-	$C_L = 50pF$, $R_L = 200k\Omega$ $t_r = t_f = 20ns$	5	7.5	7.5	pF

5. Not production testing in die form, characterized by chip design and tested in package.

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